



UltraFast
Innovations



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Soft X-ray / XUV / VUV Spectrometer EVEREST

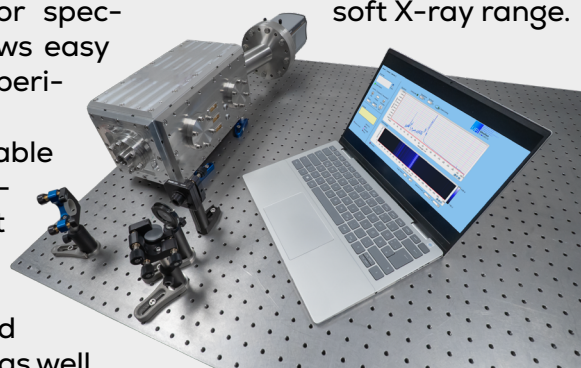


Our spectrograph EVEREST provides aberration-corrected flat-field imaging for precise and efficient characterization of radiation in the soft X-ray, XUV, and VUV spectral ranges.

Its compact, flexible design supports measurements with or without an entrance slit, allowing users to maximize either spectral resolution or light collection efficiency depending on

their experiment. An integrated filter holder accommodates thin metallic filters for spectral selection and allows easy switching between experimental configurations. EVEREST is an invaluable diagnostic tool for coherent and incoherent XUV sources, including high-harmonic generation (HHG) and laser-plasma sources, as well

as for general metrology and spectroscopy in the VUV and soft X-ray range.



Key Product Features:

- | | |
|--|---|
|  Flat-field grazing-incidence spectrograph |  User-friendly alignment, acquisition, and analysis software |
|  Wavelength coverage with single gratings: <ul style="list-style-type: none">• Soft X-Ray: 1-6 nm (206-1240 eV)• XUV: 5-20 nm / 20-80 nm (62-248 eV / 15-62 eV)• VUV: 50-200 nm (6-25 eV) |  Optional features: <ul style="list-style-type: none">• Slit-less operation and various geometry adapters• Oil-free pump system available for stand-alone vacuum operation• Beam-profiler mode – use EVEREST to characterize spatial intensity distribution of HHG or laser-plasma sources |
|  Operation with and without entrance slit | |
|  Integrated filter holder for metallic bandpass filters | |
|  Compatible pressure range $< 10^{-6}$ mbar |  In-vacuum switching between gratings (2-4) |
|  Flexible detector choice:
X-ray CCD camera (13.5 μm or 26 μm pixel)
or MCP camera system |  Extended wavelength ranges upon request |

UltraFast Innovations GmbH
Dieselstr. 5
85748 Garching
Germany

phone: +49 89 36039 - 437
fax: +49 89 36039 - 453
info@ultrafast-innovations.com
www.ultrafast-innovations.com





WWW.OPTONLASER.COM

01 69 41 04 05
contact@optonlaser.com

Characteristics:

	Grating 1	Grating 2	Grating 3	Grating 4
Wavelength range	1-6 nm	5-20 nm	20-80 nm	50-200 nm
Photon energy range	206-1240 eV	62-248 eV	15-62 eV	6-25 eV
Resolution*	0.010 nm	0.028 nm	0.11 nm	0.28 nm
Split-less operation	optional			

* Detector-limited resolution for CCD pixel size 13.5 μm

Example Measurements:

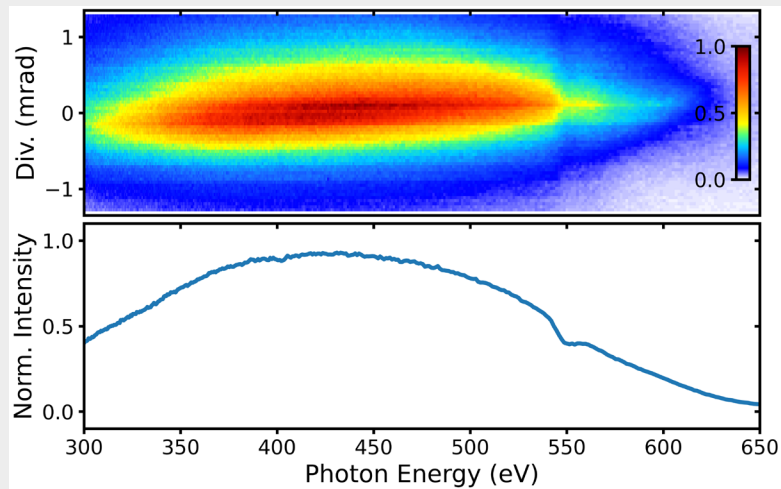


Figure 1. Soft-X-ray spectrum recorded with EVEREST. Radiation generated via HHG in gases driven by a few-cycle 2 μm OPCPA system.

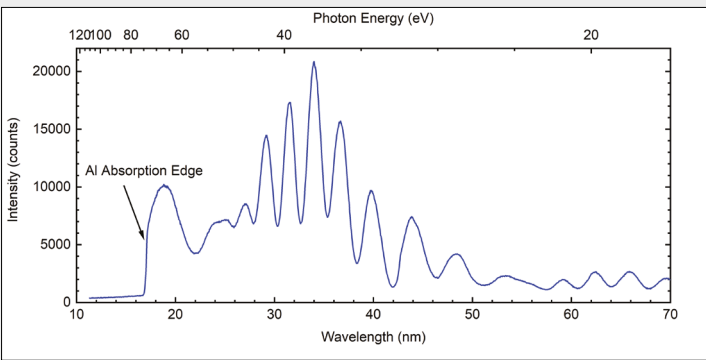
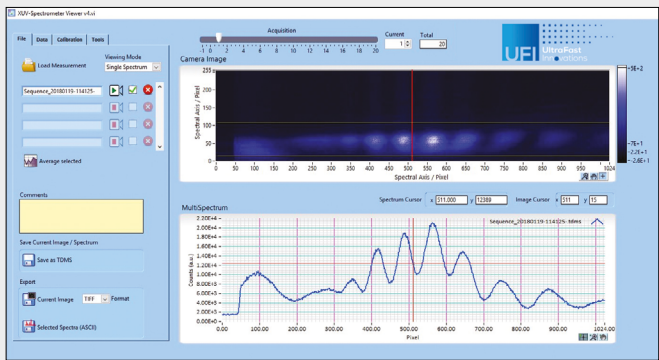


Figure 2. Left: Screenshot of our user-friendly software displaying the measurement of high-harmonic generated radiation in the XUV photon range. Right: Corresponding calibrated spectrum in wavelength and energy.

References:

[1] M. Behrens et al., Rev. Sci. Instrum. **95**, 093101 (2024)
 [2] D. Walke et al., Opt. Express **33**, 10006 (2025)